

## Notice of References Cited

Application/Control No.

09/759,915

Examiner

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Applicant(s)/Patent Under
Reexamination
TSUGANE ET AL.

Art Unit
Page 1 of 1

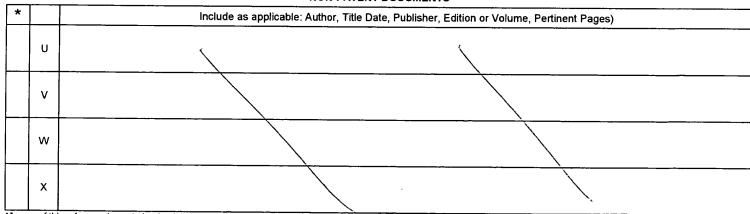
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## **NON-PATENT DOCUMENTS**



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